

Search Notes**Application/Control No.**

10/779,789

**Applicant(s)/Patent under
Reexamination**

NAKAYAMA ET AL.

Examiner

OANH DUONG

Art Unit

2155

SEARCHED

Class	Subclass	Date	Examiner
709	203,217, 219,226, 229,248	6/22/2008	O.D

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search of USPAT, JPO, EPO, DERWENT, IBM_TDB, US- PGPUB	6/22/2008	O.D